

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 12732-189001	Application No. 10/735,767
		Applicant Hideaki Kuwabara et al.	
		Filing Date December 16, 2003	Group Art Unit 2815

**Information Disclosure Statement
by Applicant**
(Use several sheets if necessary)

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
24	AA	5,861,666	01/19/1999	Bellaar			08/29/1996
	AB	6,312,304 B1	11/06/2001	Duthaler et al.			12/14/1999
	AC	6,441,474, B2	08/27/2002	Naitoh et al.			04/02/2001
30	AD	6,883,934 B2	04/26/2005	Kawakami et al.			07/12/2001
	AE						
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	AI						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
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Examiner Signature <i>Hideaki Kuwabara</i>	Date Considered 10/6/08
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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
2P	AA	2002/0030189 A1	03/14/2002	Ishikawa			09/14/2001
	AB	2002/0131007 A1	09/19/2002	Yamazaki et al.			05/01/2002
	AC	2002/0146893 A1	10/10/2002	Shimoda et al.			03/07/2002
	AD	2003/0047732 A1	03/13/2003	Yamazaki et al.			07/31/2002
	AE	2003/0231263 A1	12/18/2003	Kato et al.			11/29/2002
	AF	2004/0140547 A1	07/22/2004	Yamazaki et al.			12/09/2003
	AG	2004/0212012 A1	10/28/2004	Yamazaki et al.			01/21/2004
	AH	2004/0238827 A1	12/02/2004	Takayama et al.			03/09/2004
	AI	2005/0001211 A1	01/06/2005	Yamazaki et al.			02/10/2004
	AJ	5,804,872	09/08/1998	Miyano et al.			02/05/1997
	AK	5,834,327	11/10/1998	Yamazaki et al.			03/18/1996
	AL	6,133,626	10/17/2000	Hawke et al.			09/24/1998
	AM	6,208,521 B1	03/27/2001	Nakatsuka			05/19/1998
	AN	6,258,623 B1	07/10/2001	Moden et al.			07/08/1999
	AO	6,265,772 B1	07/24/2001	Yoshida			06/15/1999
	AP	6,388,652 B1	05/14/2002	Yamazaki et al.			08/17/1998
	AQ	6,423,614 B1	07/23/2002	Doyle			06/30/1998
	AR	6,441,474 B2	08/27/2002	Naitoh et al.			04/02/2001
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2P	AT	6,830,494 B1	12/14/2004	Yamazaki et al.			10/06/2000

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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
2P	AU	06-244360	09/02/1994	JAPAN			AB
	AV	08-186156	07/16/1996	JAPAN			AB
	AW	2000-294723	10/20/2000	JAPAN			AB
2P	AX	2002-049359	02/15/2002	JAPAN			AB

Examiner Signature <i>K. P. K. K.</i>	Date Considered <i>1/26/05</i>
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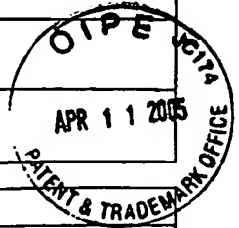
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Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
28	AY	3408154	05/19/2003	JAPAN			Full
28	AZ	EP 0 858 110 A1	08/12/1998	EUROPE			In English

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
28	AAA	<i>Exhibition of Active Matrix Type Organic EL Display at "13th Flat Panel Display Manufacturing Technology Expo & Conference"</i> by ELDis Group; July 2, 2003 (full translation)
	ABB	Documents distributed in the "13 th Flat Panel Display Manufacturing Technology Expo & Conference" by ELDis Group; July 3, 2003 (full translation)
	ACC	"Mass Production of Organic EL Devices"; <i>Shimotsuke Newspaper</i> ; July 3, 2003 (full translation)
	ADD	"Two-way display developed"; Newspaper " <i>The Japan Times</i> "; July 3, 2003
28	AEE	Watanabe et al.; "Anisotropic Conductive Films for Flat Panel Displays"; <i>AM-LCD/IDW '96</i> ; pp. 369-372; November 27, 1996

Examiner Signature <i>H. P. K. A. S. H.</i>	Date Considered <i>10/6/03</i>
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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
2P	AA	2003-0025118	02/06/2003	YAMAZAKI et al.			07/22/2002
	AB	2003-0032210	02/13/2003	TAKAYAMA et al.			07/15/2002
	AC	2003-0047280	03/13/2003	TAKAYAMA et al.			08/14/2002
	AD	2003-0064569	04/03/2003	TAKAYAMA et al.			08/09/2002
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	AG	2004-0087110	05/06/2004	TAKAYAMA et al.			07/15/2003
	AH	2004-0121516	06/24/2004	YAMAZAKI et al.			12/08/2003
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Foreign Patent Documents or Published Foreign Patent Applications

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							Yes	No
2P	AL	JP2000-061785	29 FEB 2000	JAPAN			Abstract	
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	AN							
	AO							
	AP							

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Examiner Signature <i>K. Picard</i>	Date Considered <i>10/6/05</i>
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Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Hideaki Kuwabara et al.	
		Filing Date December 16, 2003	Group Art Unit Unknown

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Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
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	AB	5,317,236	05/31/1994	Zavracky et al.			12/31/1991
	AC	5,376,561	12/27/1994	Vu et al.			04/24/1992
	AD	5,821,138	10/13/1998	Yamazaki et al.			02/16/1996
	AE	6,043,800	03/28/2000	Spitzer et al.			06/06/1995
	AF	6,127,199	10/03/2000	Inoue et al.			07/10/1998
	AG	6,372,608	04/16/2002	Shimoda et al.			04/24/1998
W	AH	6,376,333	04/23/2002	Yamazaki et al.			02/14/2000
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							Yes	No
W	AL	10-125929	05/15/1998	JAPAN			ABS	
W	AM	10-125930	05/15/1998	JAPAN			ABS	
W	AN	10-125931	05/15/1998	JAPAN			ABS	
	AO							
	AP							

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